

### 4N70-TC4

### **Power MOSFET**

## 4A, 700V N-CHANNEL POWER MOSFET

#### DESCRIPTION

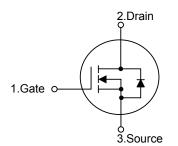
The UTC **4N70-TC4** is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC **4N70-TC4** is generally applied in high efficiency switch mode power supplies.

#### FEATURES

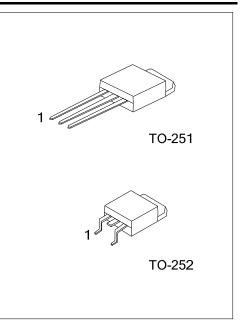
\*  $R_{DS(ON)} \le 3.5\Omega$  @  $V_{GS}$ =10V,  $I_D$ =2.0A \* High Switching Speed

SYMBOL









#### ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>c</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V <sub>DSS</sub>	700	V	
Gate-Source Voltage		V <sub>GSS</sub>	± 30	V	
Drain Current	Continuous	ID	4	А	
	Pulsed (Note 2)	I <sub>DM</sub>	8	А	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	10	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.4	V/ns	
Power Dissipation		PD	50	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 10mH,  $I_{AS}$  = 1.4A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$  Starting  $T_J$  = 25°C

4.  $I_{SD} \leq 4A$ , di/dt  $\leq 100A/\mu s$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 

#### THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	θ <sub>JC</sub>	2.5 (Note)	°C/W	

Note: Device mounted on FR-4 substrate P<sub>C</sub> board, 2oz copper, with 1inch square copper plate.



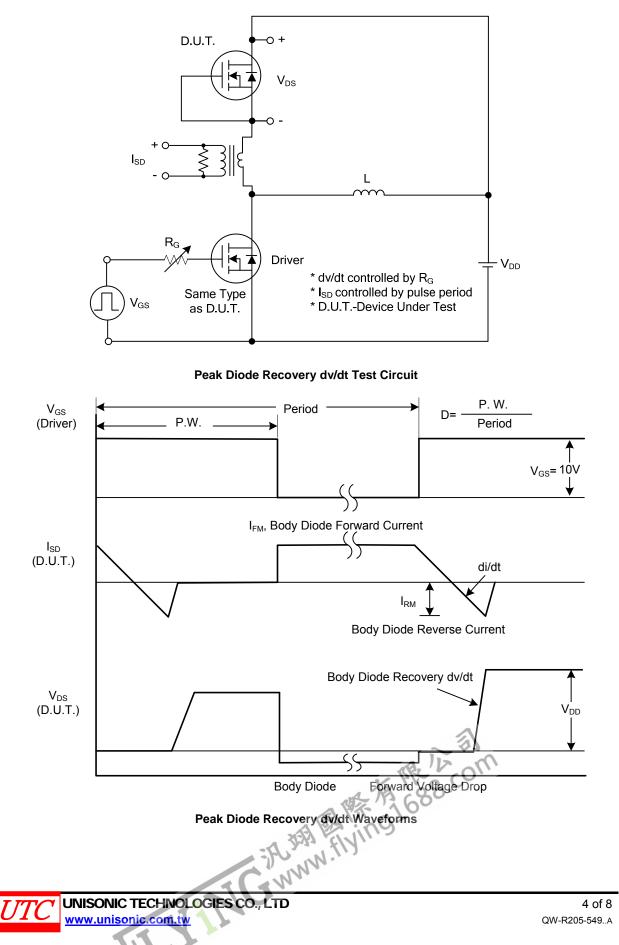
#### ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> = 250µA	700			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =700V, V <sub>GS</sub> =0V			10	μA
Gate-Source Leakage Current	Forward	I <sub>GSS</sub>	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V			100	nA
	Reverse		V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V <sub>GS(TH)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Res	istance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2.0A		3.0	3.5	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		CISS	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0 MHz		500		pF
Output Capacitance		Coss			47		pF
Reverse Transfer Capacitance					3		рF
SWITCHING CHARACTERISTICS	S						
Total Gate Charge (Note 1)		$Q_{G}$	V <sub>DS</sub> =560V, V <sub>GS</sub> =10V, I <sub>D</sub> =4A I <sub>G</sub> =1mA (Note 1, 2)		11		nC
Gateource Charge		$Q_{GS}$			3.5		nC
Gate-Drain Charge		$Q_{GD}$			1.5		nC
Turn-on Delay Time (Note 1)		t <sub>D(ON)</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =4A, R <sub>G</sub> =25Ω (Note 1, 2)		5		ns
Rise Time		t <sub>R</sub>			15		ns
Turn-off Delay Time		t <sub>D(OFF)</sub>			34		ns
Fall-Time		t⊨			25		ns
SOURCE- DRAIN DIODE RATING	GS AND CH	ARACTERIS	TICS				
Maximum Continuous Drain-Source Diode						4	А
Forward Current		ls				4	A
Maximum Pulsed Drain-Source Diode		1				8	А
Forward Current		I <sub>SM</sub>				0	А
Drain-Source Diode Forward Volta	ige (Note 1)	$V_{SD}$	I <sub>S</sub> =4A, V <sub>GS</sub> =0V			1.4	V
Reverse Recovery Time (Note 1)		t <sub>rr</sub>	I <sub>S</sub> =4A, V <sub>GS</sub> =0V		250		ns
Reverse Recovery Charge		Q <sub>rr</sub>	dI <sub>F</sub> /dt=100A/µs (Note1)		2		μC

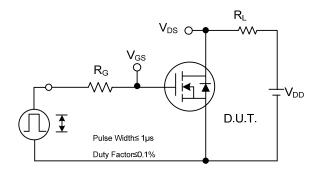
Notes: 1. Pulse Test : Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2%.

2. Essentially independent of operating temperature.

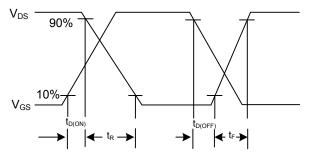
#### TEST CIRCUITS AND WAVEFORMS



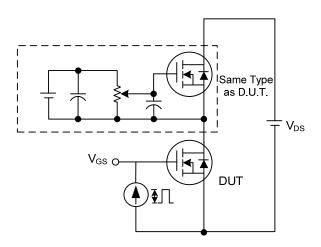
#### **TEST CIRCUITS AND WAVEFORMS**



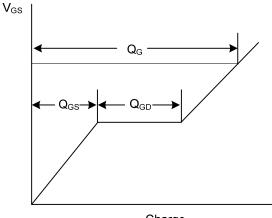
**Switching Test Circuit** 



Switching Waveforms

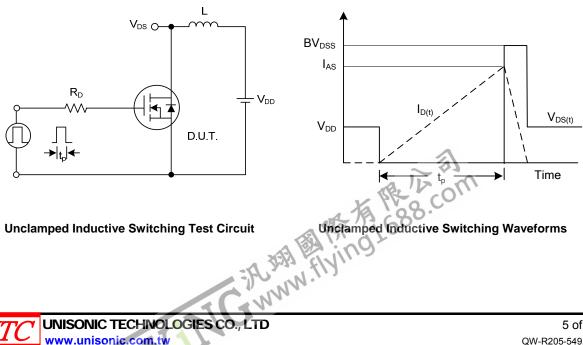


**Gate Charge Test Circuit** 



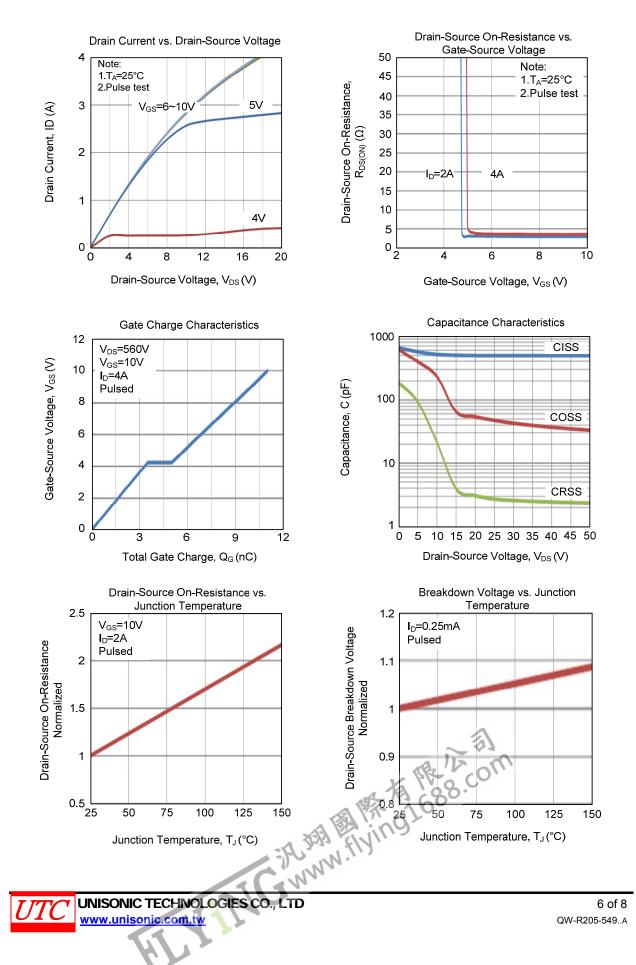
Charge





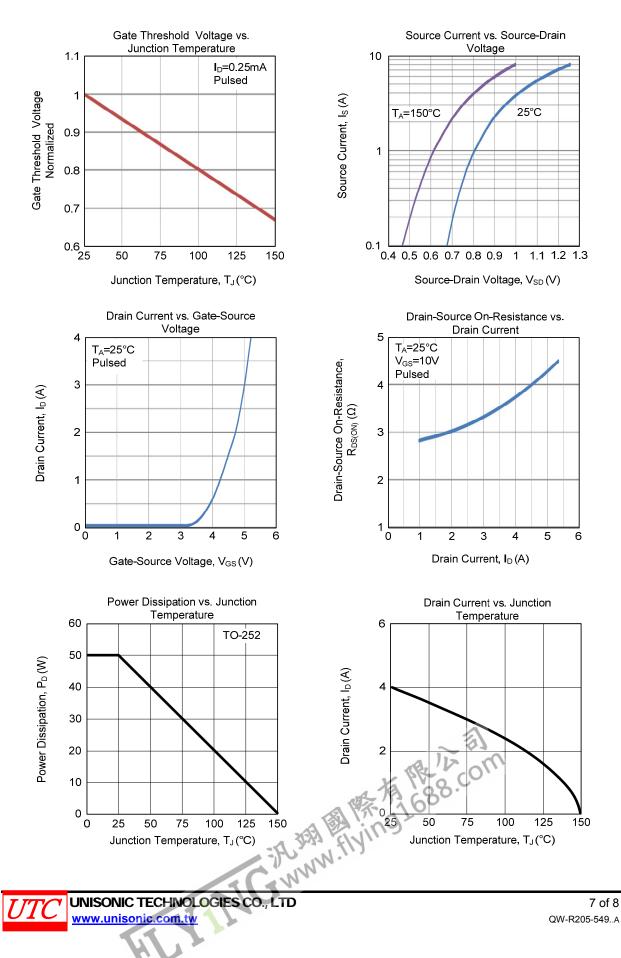
5 of 8 QW-R205-549..A

### TYPICAL CHARACTERISTICS



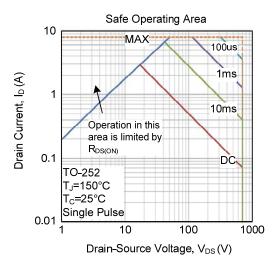
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### TYPICAL CHARACTERISTICS (Cont.)



# 4N70-TC4

### TYPICAL CHARACTERISTICS (Cont.)



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